

Search Notes

Application/Control No.

10/765,523

Examiner

Shin-Hon Chen

Applicant(s)/Patent under
Reexamination

BURCH ET AL.

Art Unit

2131

SEARCHED

Class	Subclass	Date	Examiner
726	5	5/8/2007	S.C.
705	37	5/8/2007	S.C.
380	25,28,9	5/8/2007	S.C.
709	223,224,2	5/8/2007	S.C.
713	150,156	5/8/2007	S.C.

INTERFERENCE SEARCHED

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380	25,28,9	5/8/2007	S.C.
709/223,224,2; 713/150,156		5/8/2007	S.C.

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search- see search history)	9/6/2007	S.C.